

***** CORRECT ***** (VERSION November 3, 2014) 19-May-2015

INPUT PARAMETER VALUES

SPACE_GROUP_NUMBER= 1 as used in the INTEGRATE step
UNIT_CELL_CONSTANTS= 36.908 78.959 78.947 89.976 89.958 90.002 as used by INTEGRATE
FRIEDEL'S_LAW=TRUE
PROFILE_FITTING= TRUE
OVERLOAD= 65000 MINPK= 75.00000 WFAC1= 1.0
INCLUDE_RESOLUTION_RANGE= 50.000 0.000
NAME_TEMPLATE_OF_DATA_FRAMES=../img/prefix_1_?????.img SMV
DATA_RANGE= 1 180
ROTATION_AXIS= -0.999999 0.000942 0.000546
OSCILLATION_RANGE= 1.000000
STARTING_ANGLE= 0.000 STARTING_FRAME= 1
X-RAY_WAVELENGTH= 0.979263
INCIDENT_BEAM_DIRECTION= -0.002920 -0.003140 1.021167
FRACTION_OF_POLARIZATION= 0.950
POLARIZATION_PLANE_NORMAL= 0.000000 1.000000 0.000000
AIR= 0.00100
DETECTOR=ADSC
SILICON= 3.704237 SENSOR_THICKNESS= 0.000000
NUMBER_OF_DETECTOR_SEGMENTS 1
NX= 3072 NY= 3072 QX= 0.102592 QY= 0.102592
ORGX= 1539.93 ORGY= 1545.23
DETECTOR_DISTANCE= 140.310
DIRECTION_OF_DETECTOR_X-AXIS= 1.00000 0.00000 0.00000
DIRECTION_OF_DETECTOR_Y-AXIS= 0.00000 1.00000 0.00000
BEAM_DIVERGENCE_E.S.D.= 0.065
REFLECTING_RANGE_E.S.D.= 0.128
MINIMUM_ZETA= 0.050
MAXIMUM_ERROR_OF_SPOT_POSITION= 3.0
MAXIMUM_ERROR_OF_SPINDLE_POSITION= 2.0
MINIMUM_I/SIGMA= 3.0
REFLECTIONS/CORRECTION_FACTOR= 50
STRICT_ABSORPTION_CORRECTION=FALSE
CORRECTIONS= DECAY MODULATION ABSORPTION
REFERENCE_DATA_SET=

566652 REFLECTIONS ON FILE "INTEGRATE.HKL"
0 CORRUPTED REFLECTION RECORDS (IGNORED)
0 MATCHING REFLECTIONS SPECIFIED IN FILE "FILTER.HKL"
0 REFLECTIONS INCOMPLETE OR OUTSIDE IMAGE RANGE 1 ... 180
2235 OVERLOADED REFLECTIONS (IGNORED)
234 REFLECTIONS OUTSIDE ACCEPTED RESOLUTION RANGES
OR TOO CLOSE TO ROTATION AXIS (IGNORED)
564183 REFLECTIONS ACCEPTED

AUTOMATIC SPACE GROUP ASSIGNMENT

XDS adopts the following approach.

- (1) it looks for possible symmetries of the crystal lattice
- (2) it computes a redundancy independent R-factor for all enantiomorphous point groups compatible with the observed lattice symmetry.
- (3) it selects the group which explains the intensity data at an acceptable, redundancy-independent R-factor (Rmeas, Rrim) using a minimum number of unique reflections.

This approach does not test for the presence of screw axes. Consequently, orthorhombic cell axes will be specified in increasing length (following conventions), despite the possibility that different assignments for the cell axes could become necessary for space groups P222(1) and P2(1)2(1)2 containing one or two screw axes, respectively.

The user can always override the automatic decisions by specifying the correct space group number and unit cell constants in XDS.INP and repeating the CORRECT step of XDS. This provides a simple way to rename orthorhombic cell constants if screw axes are present.

In addition, the user has the option to specify in XDS.INP

- (a) a reference data set or
 - (b) a reindexing transformation or
 - (c) the three basis vectors (if known from processing a previous data set taken at the same crystal orientation in a multi-wavelength experiment).
- These features of XDS are useful for resolving the issue of alternative settings of polar or rhombohedral cells (like P4, P6, R3).

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=====> Specifications provided by the user in XDS.INP:
SPACE_GROUP_NUMBER=      0 (0: unknown symmetry and unit cell)
UNIT_CELL_CONSTANTS=      0.00      0.00      0.00      0.000      0.000      0.000
UNIT_CELL_A-AXIS=      0.000      0.000      0.000 (0 0 0 : unknown)
UNIT_CELL_B-AXIS=      0.000      0.000      0.000 (0 0 0 : unknown)
UNIT_CELL_C-AXIS=      0.000      0.000      0.000 (0 0 0 : unknown)
REIDX=  0  0  0  0  0  0  0  0  0  0  0  0 (all 0 : not specified)
TEST_RESOLUTION_RANGE=   10.00      5.00 (Angstrom) for space group determination
NUMBER OF ACCEPTED REFLECTIONS FOR CALCULATING Rmeas      5566
NUMBER OF ACCEPTED UNIQUE REFLECTIONS FROM REFERENCE DATA SET      0
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***** DETERMINATION OF LATTICE CHARACTER AND BRAVAIS LATTICE *****

The CHARACTER OF A LATTICE is defined by the metrical parameters of its reduced cell as described in the INTERNATIONAL TABLES FOR CRYSTALLOGRAPHY Volume A, p. 746 (KLUWER ACADEMIC PUBLISHERS, DORDRECHT/BOSTON/LONDON, 1989). Note that more than one lattice character may have the same BRAVAIS LATTICE.

A lattice character is marked "*" to indicate a lattice consistent with the observed locations of the diffraction spots. These marked lattices must have low values for the QUALITY OF FIT and their implicated UNIT CELL CONSTANTS should not violate the ideal values by more than

MAX_CELL_AXIS_ERROR= 0.03
 MAX_CELL_ANGLE_ERROR= 3.0 (Degrees)

The REINDEXING TRANSFORMATION REIDX() consists of 12 integers that relate the original indices H,K,L from file INTEGRATE.HKL to the indices H',K',L' with respect to the new cell.

$$H' = (\text{REIDX}(1) * H + \text{REIDX}(2) * K + \text{REIDX}(3) * L) / \text{IDXV} + \text{REIDX}(4)$$

$$K' = (\text{REIDX}(5) * H + \text{REIDX}(6) * K + \text{REIDX}(7) * L) / \text{IDXV} + \text{REIDX}(8)$$

$$L' = (\text{REIDX}(9) * H + \text{REIDX}(10) * K + \text{REIDX}(11) * L) / \text{IDXV} + \text{REIDX}(12)$$

The value of the integer IDXV depends on the lattice type used for specifying reflections on file INTEGRATE.HKL; IDXV is

- 1 for a primitive,
- 2 for a face or body centred,
- 3 for a rhombohedral,
- 4 for a lattice centred on all faces.

IDXV is set by XDS and cannot be input by the user.

LATTICE-CHARACTER		BRAVAIS-LATTICE	QUALITY OF FIT	UNIT CELL CONSTANTS (ANGSTROMS & DEGREES)						REINDEXING TRANSFORMATION											
				a	b	c	alpha	beta	gamma												
*	31	aP	0.0	36.9	78.9	78.9	90.0	90.0	90.0	1	0	0	0	0	1	0	0	0	0	1	0
*	44	aP	0.0	36.9	78.9	78.9	90.0	90.0	90.0	-1	0	0	0	0	1	0	0	0	0	-1	0
*	34	mP	0.2	36.9	78.9	78.9	90.0	90.0	90.0	1	0	0	0	0	1	0	0	0	-1	0	0
*	33	mP	0.4	36.9	78.9	78.9	90.0	90.0	90.0	1	0	0	0	0	0	1	0	0	-1	0	0
*	35	mP	0.4	78.9	36.9	78.9	90.0	90.0	90.0	0	-1	0	0	1	0	0	0	0	0	1	0
*	20	mC	0.5	111.6	111.6	36.9	90.0	90.0	90.0	0	1	1	0	0	1	-1	0	-1	0	0	0
*	32	oP	0.6	36.9	78.9	78.9	90.0	90.0	90.0	-1	0	0	0	0	1	0	0	0	0	-1	0
*	23	oC	0.6	111.6	111.6	36.9	90.0	90.0	90.0	0	1	-1	0	0	-1	-1	0	-1	0	0	0
*	25	mC	0.6	111.6	111.6	36.9	90.0	90.0	90.0	0	1	-1	0	0	-1	-1	0	-1	0	0	0
*	21	tP	0.8	78.9	78.9	36.9	90.0	90.0	90.0	0	1	0	0	0	0	-1	0	-1	0	0	0
	39	mC	249.7	162.1	36.9	78.9	90.0	90.0	76.9	1	-2	0	0	1	0	0	0	0	0	1	0
	29	mC	249.8	36.9	162.1	78.9	90.0	90.0	76.9	1	0	0	0	1	-2	0	0	0	0	-1	0
	38	oC	249.8	36.9	162.1	78.9	90.0	90.0	103.1	1	0	0	0	-1	2	0	0	0	0	1	0
	37	mC	249.9	162.1	36.9	78.9	90.0	90.0	76.9	1	-2	0	0	1	0	0	0	0	0	1	0
	28	mC	249.9	36.9	162.1	78.9	90.0	90.0	76.9	1	0	0	0	1	-2	0	0	0	0	-1	0
	36	oC	250.0	36.9	162.1	78.9	90.0	90.0	103.1	1	0	0	0	-1	2	0	0	0	0	1	0
	27	mC	499.7	162.1	36.9	111.6	90.0	133.5	76.9	-1	2	0	0	-1	0	0	0	0	-1	1	0
	19	oI	499.9	36.9	111.6	117.6	90.0	71.7	90.0	-1	0	0	0	0	-1	1	0	-1	1	1	0
	26	oF	624.5	36.9	162.1	162.1	87.0	103.2	103.1	1	0	0	0	-1	2	0	0	-1	0	2	0
	18	tI	624.7	111.6	117.6	36.9	71.7	90.0	90.0	0	-1	1	0	1	-1	-1	0	1	0	0	0
	1	cF	999.0	117.6	117.6	117.6	95.7	95.6	143.4	1	-1	1	0	1	1	-1	0	-1	1	1	0
	2	hR	999.0	87.1	87.1	117.6	118.4	61.6	100.3	1	-1	0	0	-1	0	1	0	-1	-1	-1	0
	3	cP	999.0	36.9	78.9	78.9	90.0	90.0	90.0	-1	0	0	0	0	1	0	0	0	0	-1	0
	5	cI	999.0	87.1	87.1	111.6	50.2	50.2	79.7	-1	0	-1	0	-1	1	0	0	0	1	-1	0
	4	hR	999.0	87.1	87.1	117.6	118.4	61.6	100.3	-1	-1	0	0	1	0	-1	0	1	-1	1	0
	6	tI	999.0	111.6	87.1	87.1	79.7	50.2	50.2	0	1	-1	0	-1	0	-1	0	-1	1	0	0
	7	tI	999.0	87.1	87.1	111.6	50.2	50.2	79.7	-1	0	-1	0	-1	1	0	0	0	1	-1	0
	8	oI	999.0	87.1	87.1	111.6	50.2	50.2	79.7	1	-1	0	0	1	0	1	0	0	-1	1	0
	9	hR	999.0	36.9	87.1	252.4	102.8	98.4	115.0	1	0	0	0	-1	1	0	0	-1	-1	3	0
	10	mC	999.0	87.1	87.1	78.9	90.0	90.0	129.9	1	1	0	0	1	-1	0	0	0	0	-1	0
	11	tP	999.0	36.9	78.9	78.9	90.0	90.0	90.0	-1	0	0	0	0	1	0	0	0	0	-1	0
	12	hP	999.0	36.9	78.9	78.9	90.0	90.0	90.0	-1	0	0	0	0	1	0	0	0	0	-1	0
	13	oC	999.0	87.1	87.1	78.9	90.0	90.0	50.1	-1	1	0	0	1	1	0	0	0	0	-1	0

15	tI	999.0	36.9	78.9	180.3	64.0	78.2	90.0	1	0	0	0	0	0	1	0	1	-2	1	0
16	oF	999.0	87.1	87.1	180.3	108.0	118.9	50.1	1	-1	0	0	-1	-1	0	0	-1	1	-2	0
14	mC	999.0	87.1	87.1	78.9	90.0	90.0	50.1	-1	1	0	0	1	1	0	0	0	0	-1	0
17	mC	999.0	87.1	87.1	87.1	79.7	100.3	50.1	-1	-1	0	0	1	-1	0	0	1	0	1	0
22	hP	999.0	78.9	78.9	36.9	90.0	90.0	90.0	0	1	0	0	0	0	-1	0	-1	0	0	0
24	hR	999.0	180.3	111.6	36.9	90.0	78.2	108.0	1	-1	2	0	0	-1	-1	0	1	0	0	0
30	mC	999.0	78.9	176.5	36.9	90.0	90.0	63.4	0	1	0	0	0	1	-2	0	-1	0	0	0
40	oC	999.0	78.9	176.5	36.9	90.0	90.0	116.6	0	-1	0	0	0	1	-2	0	1	0	0	0
42	oI	999.0	36.9	78.9	180.3	116.0	101.8	90.0	-1	0	0	0	0	0	-1	0	1	-2	1	0
41	mC	999.0	176.5	78.9	36.9	90.0	90.0	63.4	0	2	-1	0	0	0	-1	0	-1	0	0	0
43	mI	999.0	87.1	180.3	78.9	116.0	154.9	61.1	-1	1	0	0	-1	1	-2	0	0	-1	0	0

***** LATTICE SYMMETRY IMPLICATED BY SPACE GROUP SYMMETRY *****

BRAVAIS- TYPE	POSSIBLE SPACE-GROUPS FOR PROTEIN CRYSTALS [SPACE GROUP NUMBER,SYMBOL]
aP	[1,P1]
mP	[3,P2] [4,P2(1)]
mC, mI	[5,C2]
oP	[16,P222] [17,P222(1)] [18,P2(1)2(1)2] [19,P2(1)2(1)2(1)]
oC	[21,C222] [20,C222(1)]
oF	[22,F222]
oI	[23,I222] [24,I2(1)2(1)2(1)]
tP	[75,P4] [76,P4(1)] [77,P4(2)] [78,P4(3)] [89,P422] [90,P42(1)2]
	[91,P4(1)22] [92,P4(1)2(1)2] [93,P4(2)22] [94,P4(2)2(1)2]
	[95,P4(3)22] [96,P4(3)2(1)2]
tI	[79,I4] [80,I4(1)] [97,I422] [98,I4(1)22]
hP	[143,P3] [144,P3(1)] [145,P3(2)] [149,P312] [150,P321] [151,P3(1)12]
	[152,P3(1)21] [153,P3(2)12] [154,P3(2)21] [168,P6] [169,P6(1)]
	[170,P6(5)] [171,P6(2)] [172,P6(4)] [173,P6(3)] [177,P622]
	[178,P6(1)22] [179,P6(5)22] [180,P6(2)22] [181,P6(4)22] [182,P6(3)22]
hR	[146,R3] [155,R32]
cP	[195,P23] [198,P2(1)3] [207,P432] [208,P4(2)32] [212,P4(3)32]
	[213,P4(1)32]
cF	[196,F23] [209,F432] [210,F4(1)32]
cI	[197,I23] [199,I2(1)3] [211,I432] [214,I4(1)32]

***** SYMMETRY OF REFLECTION INTENSITIES *****

Analysis of symmetry related reflections is based on strong data within a
TEST_RESOLUTION_RANGE= 10.00 5.00 Angstrom (defined in XDS.INP).

The symmetry test is carried out for the enantiomorphous space groups above
(omitting those with screw axes) that conform with the observed lattice
symmetry. The test is quantified by the redundancy independent R-factor,
Rmeas, defined by Diederichs & Karplus, Nature Struct. Biol. 4, 269-275 (1997).

For computation of Rmeas a minimum number of symmetry-related reflections is
required and set by the user (in XDS.INP) as the parameter
MIN_RFL_Rmeas= 50

Low values for Rmeas should be obtained if the crystal possesses the symmetry

elements of the tested space group. The decision whether the crystal's data satisfy the requirements of the tested space group is based on a constant set by the user (in XDS.INP) as the parameter

MAX_FAC_Rmeas= 2.

which provides an upper limit for acceptable Rmeas as a multiple of the lowest Rmeas found for all tested space groups. If Rmeas is larger than this upper limit, the corresponding space group symmetry is considered violated by the observed data.

XDS will select (*) that space group that requires a minimum number of unique reflections to account for the observed intensities at an acceptable Rmeas.

UNIQUE = number of unique reflections

Rmeas = redundancy independent R-factor (intensities)

COMPARED = number of reflections used for calculating Rmeas

SPACE-GROUP NUMBER	a	b	c	alpha	beta	gamma	UNIQUE	Rmeas	COMPARED	LATTICE- CHARACTER
5	111.6	111.6	36.9	90.0	90.0	90.0	1655	3.8	3911	20 mC
75	78.9	78.9	36.9	90.0	90.0	90.0	896	4.6	4670	21 tP
* 89	78.9	78.9	36.9	90.0	90.0	90.0	507	4.5	5059	21 tP
21	111.6	111.6	36.9	90.0	90.0	90.0	930	4.3	4636	23 oC
5	111.6	111.6	36.9	90.0	90.0	90.0	1656	4.2	3910	25 mC
1	36.9	78.9	78.9	90.0	90.0	90.0	3016	3.6	2550	31 aP
16	36.9	78.9	78.9	90.0	90.0	90.0	959	4.5	4607	32 oP
3	78.9	36.9	78.9	90.0	90.0	90.0	1720	4.3	3846	35 mP
3	36.9	78.9	78.9	90.0	90.0	90.0	1685	4.7	3881	34 mP
1	36.9	78.9	78.9	90.0	90.0	90.0	3016	3.6	2550	44 aP



***** SELECTED SPACE GROUP AND UNIT CELL FOR THIS DATA SET *****

SPACE_GROUP_NUMBER= 89

UNIT_CELL_CONSTANTS= 78.94 78.94 36.90 90.000 90.000 90.000

UNIT_CELL_A-AXIS= -64.886 16.823 -41.693

UNIT_CELL_B-AXIS= 38.033 -18.519 -66.653

UNIT_CELL_C-AXIS= -11.200 -34.999 3.332

REFLECTIONS H,K,L FROM "INTEGRATE.HKL" WILL BE REINDEXED BY

H' = (0*H + 1*K + 0*L)/ 1 + 0

K' = (0*H + 0*K + -1*L)/ 1 + 0

L' = (-1*H + 0*K + 0*L)/ 1 + 0

***** 8 EQUIVALENT POSITIONS IN SPACE GROUP # 89 *****

If x',y',z' is an equivalent position to x,y,z, then

x'=x*ML(1)+y*ML(2)+z*ML(3)+ML(4)/12.0

y'=x*ML(5)+y*ML(6)+z*ML(7)+ML(8)/12.0

z'=x*ML(9)+y*ML(10)+z*ML(11)+ML(12)/12.0

#	1	2	3	4	5	6	7	8	9	10	11	12
1	1	0	0	0	0	1	0	0	0	0	1	0
2	-1	0	0	0	0	-1	0	0	0	0	1	0

3	-1	0	0	0	0	1	0	0	0	0	-1	0
4	1	0	0	0	0	-1	0	0	0	0	-1	0
5	0	-1	0	0	-1	0	0	0	0	0	-1	0
6	0	1	0	0	1	0	0	0	0	0	-1	0
7	0	1	0	0	-1	0	0	0	0	0	1	0
8	0	-1	0	0	1	0	0	0	0	0	1	0

 MEAN DISCREPANCIES BETWEEN OBSERVED AND CALCULATED SPOT LOCATIONS

The discrepancies in X- and Y-coordinates of the spots are depicted in the two images DX-CORRECTIONS.cbf and DY-CORRECTIONS.cbf for inspection with the XDS-Viewer.

 REFINEMENT OF DIFFRACTION PARAMETERS USING ALL IMAGES

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REFINED VALUES OF DIFFRACTION PARAMETERS DERIVED FROM 395935 INDEXED SPOTS
REFINED PARAMETERS:  DISTANCE BEAM ORIENTATION CELL AXIS
STANDARD DEVIATION OF SPOT POSITION (PIXELS) 0.74
STANDARD DEVIATION OF SPINDLE POSITION (DEGREES) 0.14
SPACE GROUP NUMBER 89
UNIT CELL PARAMETERS 78.977 78.977 36.914 90.000 90.000 90.000
E.S.D. OF CELL PARAMETERS 5.1E-03 5.1E-03 8.7E-03 0.0E+00 0.0E+00 0.0E+00
REC. CELL PARAMETERS 0.012662 0.012662 0.027090 90.000 90.000 90.000
COORDINATES OF UNIT CELL A-AXIS -64.921 16.823 -41.709
COORDINATES OF UNIT CELL B-AXIS 38.045 -18.515 -66.687
COORDINATES OF UNIT CELL C-AXIS -11.210 -35.013 3.326
CRYSTAL MOSAICITY (DEGREES) 0.128
LAB COORDINATES OF ROTATION AXIS -0.999999 0.000913 0.000678
DIRECT BEAM COORDINATES (REC. ANGSTROM) -0.002886 -0.003124 1.021167
DETECTOR COORDINATES (PIXELS) OF DIRECT BEAM 1535.79 1540.87
DETECTOR ORIGIN (PIXELS) AT 1539.65 1545.06
CRYSTAL TO DETECTOR DISTANCE (mm) 140.35
LAB COORDINATES OF DETECTOR X-AXIS 1.000000 0.000000 0.000000
LAB COORDINATES OF DETECTOR Y-AXIS 0.000000 1.000000 0.000000

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THE DATA COLLECTION STATISTICS REPORTED BELOW ASSUMES:
SPACE_GROUP_NUMBER= 89
UNIT_CELL_CONSTANTS= 78.98 78.98 36.91 90.000 90.000 90.000

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 MEAN INTENSITY AS FUNCTION OF SPINDLE POSITION WITHIN DATA IMAGE

This statistics could serve as a diagnostic tool for detecting

shutter problems (suggested by Kay Diederichs).
 Data are corrected for this effect if PATCH_SHUTTER_PROBLEM=TRUE in XDS.INP.
 ==> Selected : PATCH_SHUTTER_PROBLEM=FALSE

INTERVAL = Angular interval in units of the oscillation range
 covered by a data image.
 NUMBER = Number of reflections in each interval
 INTENSITY= Mean intensity of the reflections in each interval
 FACTOR = Correction factor applied to intensities;
 INTENSITY(overall)/INTENSITY(interval)

INTERVAL	NUMBER	INTENSITY	FACTOR
-0.05 0.05	56404	4110.100	0.963
0.05 0.15	56105	4012.067	0.986
0.15 0.25	56411	3926.565	1.008
0.25 0.35	56086	3986.169	0.993
0.35 0.45	56415	3926.063	1.008
0.45 0.55	56647	3920.445	1.009
0.55 0.65	56642	3877.295	1.021
0.65 0.75	56541	3897.729	1.015
0.75 0.85	56190	3974.544	0.996
0.85 0.95	56742	3939.798	1.004
-0.05 0.95	564183	3956.950	1.000

 CORRECTION FACTORS AS FUNCTION OF IMAGE NUMBER & RESOLUTION

RECIPROCAL CORRECTION FACTORS FOR INPUT DATA SETS MERGED TO
 OUTPUT FILE: XDS_ASCII.HKL

THE CALCULATIONS ASSUME FRIEDEL'S_LAW= TRUE
 TOTAL NUMBER OF CORRECTION FACTORS DEFINED 660
 DEGREES OF FREEDOM OF CHI^2 FIT 368398.9
 CHI^2-VALUE OF FIT OF CORRECTION FACTORS 0.982
 NUMBER OF CYCLES CARRIED OUT 3

CORRECTION FACTORS for visual inspection by XDS-Viewer DECAY.cbf
 XMIN= 0.1 XMAX= 163.9 NXBIN= 33
 YMIN= 0.00064 YMAX= 0.96824 NYBIN= 20
 NUMBER OF REFLECTIONS USED FOR DETERMINING CORRECTION FACTORS 411311

 CORRECTION FACTORS AS FUNCTION OF X (fast) & Y(slow) IN THE DETECTOR PLANE

RECIPROCAL CORRECTION FACTORS FOR INPUT DATA SETS MERGED TO
 OUTPUT FILE: XDS_ASCII.HKL

THE CALCULATIONS ASSUME FRIEDEL'S_LAW= TRUE

TOTAL NUMBER OF CORRECTION FACTORS DEFINED 8190
DEGREES OF FREEDOM OF CHI^2 FIT 368190.8
CHI^2-VALUE OF FIT OF CORRECTION FACTORS 0.972
NUMBER OF CYCLES CARRIED OUT 3

CORRECTION FACTORS for visual inspection by XDS-Viewer MODPIX.cbf
XMIN= 3.6 XMAX= 3068.4 NXBIN= 91
YMIN= 21.4 YMAX= 3051.7 NYBIN= 90
NUMBER OF REFLECTIONS USED FOR DETERMINING CORRECTION FACTORS 411311

CORRECTION FACTORS AS FUNCTION OF IMAGE NUMBER & DETECTOR SURFACE POSITION

RECIPROCAL CORRECTION FACTORS FOR INPUT DATA SETS MERGED TO
OUTPUT FILE: XDS_ASCII.HKL

THE CALCULATIONS ASSUME FRIEDEL'S_LAW= TRUE
TOTAL NUMBER OF CORRECTION FACTORS DEFINED 429
DEGREES OF FREEDOM OF CHI^2 FIT 368428.0
CHI^2-VALUE OF FIT OF CORRECTION FACTORS 0.965
NUMBER OF CYCLES CARRIED OUT 3

CORRECTION FACTORS for visual inspection by XDS-Viewer ABSORP.cbf
XMIN= 0.1 XMAX= 163.9 NXBIN= 33
DETECTOR_SURFACE_POSITION= 1536 1537
DETECTOR_SURFACE_POSITION= 2057 2051
DETECTOR_SURFACE_POSITION= 1015 2051
DETECTOR_SURFACE_POSITION= 1015 1022
DETECTOR_SURFACE_POSITION= 2057 1022
DETECTOR_SURFACE_POSITION= 2714 2019
DETECTOR_SURFACE_POSITION= 2024 2701
DETECTOR_SURFACE_POSITION= 1048 2701
DETECTOR_SURFACE_POSITION= 358 2019
DETECTOR_SURFACE_POSITION= 358 1054
DETECTOR_SURFACE_POSITION= 1048 372
DETECTOR_SURFACE_POSITION= 2024 372
DETECTOR_SURFACE_POSITION= 2714 1054
NUMBER OF REFLECTIONS USED FOR DETERMINING CORRECTION FACTORS 411311

CORRECTION PARAMETERS FOR THE STANDARD ERROR OF REFLECTION INTENSITIES

The variance $v_0(I)$ of the intensity I obtained from counting statistics is replaced by $v(I)=a*(v_0(I)+b*I^2)$. The model parameters a , b are chosen to minimize the discrepancies between $v(I)$ and the variance estimated from sample statistics of symmetry related reflections. This model implicates an asymptotic limit $ISa=1/\text{SQRT}(a*b)$ for the highest $I/\text{Sigma}(I)$ that the experimental setup can produce (Diederichs (2010) Acta Cryst D66, 733-740).

a b ISa
 4.850E+00 2.087E-04 31.43

 STANDARD ERROR OF REFLECTION INTENSITIES AS FUNCTION OF RESOLUTION
 FOR DATA SET XDS_ASCII.HKL

I/Sigma = mean intensity/Sigma of a reflection in shell
 Chi^2 = goodness of fit between sample variances of
 symmetry-related intensities and their errors
 (Chi^2 = 1 for perfect agreement)

R-FACTOR
 observed = (SUM(ABS(I(h,i)-I(h))))/(SUM(I(h,i)))
 expected = expected R-FACTOR derived from Sigma(I)

NUMBER = number of reflections in resolution shell
 used for calculation of R-FACTOR
 ACCEPTED = number of accepted reflections
 REJECTED = number of rejected reflections (MISFITS),
 recognized by comparison with symmetry-related
 reflections.

RESOLUTION	RANGE	1/Sigma	Chi^2	R-FACTOR observed	R-FACTOR expected	NUMBER	ACCEPTED	REJECTED
39.489	9.845	27.60	1.23	2.19	2.35	444	449	105
9.845	7.072	29.39	0.91	1.86	2.41	1230	1231	55
7.072	5.806	29.49	0.92	1.94	2.45	1811	1813	49
5.806	5.041	29.88	0.88	1.91	2.44	2217	2217	53
5.041	4.517	29.29	0.95	2.00	2.44	2278	2281	63
4.517	4.128	29.61	0.94	2.00	2.43	2499	2501	46
4.128	3.824	29.49	0.94	1.91	2.44	2795	2803	66
3.824	3.579	29.45	0.91	1.95	2.45	3137	3138	97
3.579	3.376	29.41	0.94	2.01	2.47	3261	3261	116
3.376	3.204	28.86	0.98	2.04	2.48	3791	3794	108
3.204	3.056	28.40	0.97	2.07	2.50	3788	3789	110
3.056	2.927	27.26	1.01	2.10	2.51	4012	4012	120
2.927	2.812	26.77	1.06	2.25	2.55	4219	4220	105
2.812	2.711	26.36	1.08	2.29	2.55	4101	4101	123
2.711	2.619	26.33	1.23	2.58	2.57	4296	4297	178
2.619	2.536	26.02	1.16	2.56	2.61	4565	4565	116
2.536	2.461	25.76	1.17	2.54	2.60	4609	4609	122
2.461	2.392	25.26	1.15	2.50	2.63	4846	4846	129
2.392	2.328	25.05	1.19	2.56	2.65	5088	5088	150
2.328	2.269	24.88	1.17	2.56	2.65	5085	5085	149
2.269	2.215	24.03	1.23	2.65	2.71	5212	5212	161
2.215	2.164	23.62	1.17	2.70	2.76	5359	5359	108
2.164	2.117	23.83	1.12	2.64	2.76	5622	5622	114
2.117	2.072	22.70	1.21	2.77	2.82	5438	5438	162
2.072	2.031	21.67	1.20	2.97	2.92	5796	5796	163
2.031	1.991	21.49	1.13	2.93	2.96	6029	6029	117

1.991	1.954	21.00	1.13	3.01	3.04	5972	5972	120
1.954	1.919	20.31	1.13	3.09	3.11	6181	6181	100
1.919	1.886	19.27	1.19	3.30	3.22	6115	6115	142
1.886	1.854	18.84	1.09	3.34	3.36	6374	6374	94
1.854	1.824	18.32	1.09	3.39	3.45	6539	6539	63
1.824	1.795	16.93	1.06	3.56	3.65	6717	6717	60
1.795	1.768	17.74	1.06	3.61	3.63	6535	6535	54
1.768	1.742	16.23	1.08	3.93	3.94	6857	6857	55
1.742	1.717	15.95	1.06	3.94	3.99	6802	6802	54
1.717	1.693	15.12	1.07	4.17	4.21	7106	7106	45
1.693	1.670	14.53	1.00	4.25	4.39	6963	6963	39
1.670	1.648	14.48	1.02	4.41	4.49	7321	7321	40
1.648	1.626	14.44	0.99	4.24	4.42	7344	7344	38
1.626	1.606	14.16	1.02	4.57	4.68	7155	7155	29
1.606	1.586	12.88	1.04	5.05	5.06	7644	7644	49
1.586	1.567	12.77	0.96	4.99	5.20	7494	7494	22
1.567	1.549	11.81	1.01	5.57	5.67	7660	7660	43
1.549	1.531	11.03	0.99	5.94	6.08	7528	7528	26
1.531	1.514	11.05	1.05	6.11	6.09	8059	8059	66
1.514	1.498	10.42	1.02	6.43	6.44	7755	7755	23
1.498	1.482	10.48	0.97	6.31	6.49	7905	7905	12
1.482	1.466	9.62	0.99	7.04	7.18	7999	7999	28
1.466	1.451	9.35	0.99	7.24	7.36	8155	8155	26
1.451	1.437	9.58	1.00	7.14	7.25	8117	8117	41
1.437	1.423	8.42	1.00	8.32	8.38	8270	8270	23
1.423	1.409	7.95	0.96	8.61	8.90	8078	8078	30
1.409	1.396	8.06	0.95	8.60	8.88	8712	8712	13
1.396	1.383	7.44	0.96	9.20	9.48	8375	8375	13
1.383	1.370	7.29	1.02	9.79	9.80	8541	8541	42
1.370	1.358	6.60	0.97	10.62	10.88	8555	8555	30
1.358	1.346	6.41	0.96	10.94	11.25	8772	8772	7
1.346	1.334	6.42	0.99	11.20	11.31	8794	8794	18
1.334	1.323	6.24	0.94	11.30	11.65	8655	8655	6
1.323	1.312	5.94	0.95	11.85	12.27	8907	8907	33
1.312	1.301	5.99	0.96	11.84	12.13	8816	8816	11
1.301	1.290	5.46	0.98	13.29	13.44	9211	9211	45
1.290	1.280	5.48	0.98	13.35	13.46	8911	8911	11
1.280	1.270	5.24	0.95	13.89	14.20	8934	8934	9
1.270	1.260	4.59	0.96	16.04	16.42	9442	9442	24
1.260	1.251	4.69	0.98	15.73	16.00	9070	9070	21
1.251	1.241	4.67	0.95	15.81	16.16	9345	9345	14
1.241	1.232	4.40	0.93	16.25	16.86	9274	9274	12
1.232	1.223	4.40	0.98	16.60	16.91	9549	9549	17
1.223	1.215	4.21	0.94	17.21	17.81	9321	9321	21
1.215	1.206	4.02	0.96	18.34	18.76	9595	9595	12
1.206	1.198	4.01	0.92	17.72	18.49	8364	8364	10
1.198	1.189	3.57	0.89	19.66	20.92	7629	7629	8
1.189	1.181	3.58	0.88	19.33	20.74	7081	7081	4
1.181	1.173	3.29	0.89	21.23	22.41	6643	6645	5
1.173	1.166	3.04	0.87	22.74	24.41	6136	6138	12
1.166	1.158	3.06	0.85	22.18	24.07	5684	5685	6
1.158	1.151	2.90	0.83	23.11	25.34	5374	5381	13
1.151	1.143	2.66	0.85	25.44	27.55	5032	5034	13

1.143	1.136	2.54	0.87	26.80	28.80	4972	4974	7
1.136	1.129	2.51	0.84	26.50	28.89	4372	4378	7
1.129	1.122	2.44	0.81	26.73	29.50	4154	4160	10
1.122	1.115	2.25	0.85	29.26	31.84	3728	3735	3
1.115	1.109	2.09	0.88	31.96	34.26	3697	3706	7
1.109	1.102	1.91	0.81	33.30	37.00	3216	3224	1
1.102	1.096	1.95	0.90	34.25	36.01	3101	3115	4
1.096	1.090	1.81	0.83	34.71	38.38	2723	2738	5
1.090	1.083	1.62	0.84	38.71	42.64	2578	2608	5
1.083	1.077	1.50	0.83	42.06	46.00	2297	2324	5
1.077	1.071	1.35	0.83	45.65	49.98	2096	2134	8
1.071	1.065	1.28	0.88	49.65	52.54	1860	1899	3
1.065	1.060	1.21	0.92	52.01	54.10	1609	1661	4
1.060	1.054	1.08	0.82	54.66	59.93	1352	1413	6
1.054	1.048	1.07	0.81	54.19	59.79	1207	1275	13
1.048	1.043	0.94	0.90	63.34	65.93	948	1015	4
1.043	1.037	0.86	0.86	67.54	73.23	704	779	4
1.037	1.032	0.72	0.86	77.01	81.80	603	674	3
1.032	1.027	0.88	0.70	54.69	63.61	331	406	0
1.027	1.021	0.68	0.85	74.29	79.69	158	220	2
1.021	1.016	0.65	0.71	54.74	70.58	37	70	0

39.489	1.016	11.45	1.00	3.73	4.01	558638	559445	4738

SUMMARY OF DATA SET STATISTICS FOR VARIOUS SUBSETS OF INCLUDED DATA IMAGES

Data set statistics is reported below several times, each with a different upper limit on the number of images included. This provides the user with the information for deciding which data images should be excluded from the final data set because of radiation damage or other defects. If the user decides for a subset of "good" images that differs from the specification as given by the input parameter (see DATA_RANGE= in XDS.INP) the CORRECT-step of XDS must be repeated with the new parameter values for DATA_RANGE=.

SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 21

COMPLETENESS AND QUALITY OF DATA SET

R-FACTOR

observed = $(\text{SUM}(\text{ABS}(I(h,i) - I(h)))) / (\text{SUM}(I(h,i)))$
expected = expected R-FACTOR derived from $\text{Sigma}(I)$

COMPARED = number of reflections used for calculating R-FACTOR
I/SIGMA = mean of intensity/Sigma(I) of unique reflections

Sigma(I) = (after merging symmetry-related observations)
 = standard deviation of reflection intensity I
 estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
 Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
 random half-datasets. Correlation significant at
 the 0.1% level is marked by an asterisk.
 Karplus & Diederichs (2012), Science 336, 1030-33

Anomal
 Corr = percentage of correlation between random half-sets
 of anomalous intensity differences. Correlation
 significant at the 0.1% level is marked.

SigAno = mean anomalous difference in units of its estimated
 standard deviation ($|F(+)-F(-)|/\text{Sigma}$). F(+), F(-)
 are structure factor estimates obtained from the
 merged intensity observations in each parity class.

Nano = Number of unique reflections used to calculate
 Anomal_Corr & SigAno. At least two observations
 for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION													
RESOLUTION LIMIT	NUMBER OF REFLECTIONS			COMPLETENESS OF DATA	R-FACTOR observed	R-FACTOR expected	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal Corr	SigAno	Nano
	OBSERVED	UNIQUE	POSSIBLE										
3.04	3323	1364	2499	54.6%	1.8%	2.1%	2860	44.06	2.1%	99.9*	15	0.821	236
2.15	6624	2894	4242	68.2%	2.1%	2.2%	5545	38.29	2.5%	99.8*	21*	0.932	363
1.76	8679	3921	5385	72.8%	2.3%	2.5%	7178	30.78	2.9%	99.9*	12	0.851	381
1.52	10412	4643	6314	73.5%	3.3%	3.5%	8715	22.29	4.0%	99.8*	8	0.849	501
1.36	11576	5232	7089	73.8%	5.1%	5.3%	9762	15.23	6.4%	99.5*	13	0.871	549
1.24	12705	5723	7842	73.0%	8.5%	8.6%	10929	9.92	10.7%	98.6*	9	0.839	503
1.15	11098	5729	8462	67.7%	11.7%	12.0%	8842	6.33	15.1%	96.9*	2	0.767	240
1.08	5263	4092	9086	45.0%	18.6%	19.9%	2272	3.04	26.0%	89.9*	0	0.000	0
1.02	1513	1472	9654	15.2%	41.1%	49.0%	82	1.47	58.2%	83.1*	0	0.000	0
total	71193	35070	60573	57.9%	2.8%	3.0%	56185	16.61	3.5%	99.9*	11*	0.853	2773

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 71854
 NUMBER OF REJECTED MISFITS 657
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 71197
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 35072

 SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 41

COMPLETENESS AND QUALITY OF DATA SET

R-FACTOR
observed = (SUM(ABS(I(h,i)-I(h))))/(SUM(I(h,i)))
expected = expected R-FACTOR derived from Sigma(I)

COMPARED = number of reflections used for calculating R-FACTOR
I/SIGMA = mean of intensity/Sigma(I) of unique reflections
(after merging symmetry-related observations)
Sigma(I) = standard deviation of reflection intensity I
estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
random half-datasets. Correlation significant at
the 0.1% level is marked by an asterisk.
Karplus & Diederichs (2012), Science 336, 1030-33

Anomal
Corr = percentage of correlation between random half-sets
of anomalous intensity differences. Correlation
significant at the 0.1% level is marked.

SigAno = mean anomalous difference in units of its estimated
standard deviation (|F(+)-F(-)|/Sigma). F(+), F(-)
are structure factor estimates obtained from the
merged intensity observations in each parity class.

Nano = Number of unique reflections used to calculate
Anomal_Corr & SigAno. At least two observations
for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION													
RESOLUTION LIMIT	NUMBER OF REFLECTIONS			COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal	SigAno	Nano
	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected					Corr		
3.04	6609	1821	2499	72.9%	1.8%	2.2%	6315	53.54	2.1%	99.9*	10	0.768	719
2.15	12988	3664	4242	86.4%	2.2%	2.3%	12506	47.37	2.5%	99.9*	14*	0.880	1511
1.76	17035	4842	5385	89.9%	2.6%	2.7%	16456	38.15	3.0%	99.9*	8	0.876	1969
1.52	20287	5708	6314	90.4%	3.7%	3.8%	19723	27.47	4.3%	99.8*	8	0.850	2126
1.36	22691	6408	7089	90.4%	5.8%	5.9%	22155	18.56	6.8%	99.5*	8	0.861	2086
1.24	24886	7027	7842	89.6%	9.5%	9.7%	24372	12.00	11.1%	98.8*	1	0.808	2058
1.15	21663	7283	8462	86.1%	13.4%	14.0%	20821	7.37	16.2%	97.1*	-1	0.751	1472
1.08	10276	5858	9086	64.5%	20.0%	21.4%	8040	3.38	27.1%	90.5*	0	0.676	30
1.02	2975	2364	9654	24.5%	37.2%	40.2%	1221	1.48	52.5%	73.2*	0	0.000	0
total	139410	44975	60573	74.2%	3.1%	3.3%	131609	19.85	3.6%	99.9*	5	0.835	11971

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 140635
NUMBER OF REJECTED MISFITS 1220
NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
NUMBER OF ACCEPTED OBSERVATIONS 139415
NUMBER OF UNIQUE ACCEPTED REFLECTIONS 44976

SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 61

COMPLETENESS AND QUALITY OF DATA SET

R-FACTOR
observed = (SUM(ABS(I(h,i)-I(h))))/(SUM(I(h,i)))
expected = expected R-FACTOR derived from Sigma(I)

COMPARED = number of reflections used for calculating R-FACTOR
I/SIGMA = mean of intensity/Sigma(I) of unique reflections
(after merging symmetry-related observations)
Sigma(I) = standard deviation of reflection intensity I
estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
random half-datasets. Correlation significant at
the 0.1% level is marked by an asterisk.
Karplus & Diederichs (2012), Science 336, 1030-33

Anomal
Corr = percentage of correlation between random half-sets
of anomalous intensity differences. Correlation
significant at the 0.1% level is marked.

SigAno = mean anomalous difference in units of its estimated
standard deviation (|F(+)-F(-)|/Sigma). F(+), F(-)
are structure factor estimates obtained from the
merged intensity observations in each parity class.

Nano = Number of unique reflections used to calculate
Anomal_Corr & SigAno. At least two observations
for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION													
RESOLUTION	NUMBER OF REFLECTIONS			COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal	SigAno	Nano
LIMIT	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected					Corr		
3.04	9925	2257	2499	90.3%	1.9%	2.3%	9645	59.11	2.1%	99.9*	14*	0.829	1232
2.15	19206	4193	4242	98.8%	2.3%	2.4%	18933	53.76	2.5%	99.9*	13*	0.910	2669
1.76	25239	5333	5385	99.0%	2.8%	2.8%	25032	43.92	3.1%	99.9*	9	0.901	3636
1.52	30123	6207	6314	98.3%	4.0%	4.1%	29985	31.44	4.5%	99.8*	7	0.859	4633
1.36	33752	6945	7089	98.0%	6.6%	6.6%	33593	20.96	7.4%	99.6*	4	0.850	5419
1.24	37096	7701	7842	98.2%	10.8%	10.8%	36950	13.39	12.1%	98.9*	-1	0.802	5845
1.15	32187	8192	8462	96.8%	15.3%	15.7%	31677	8.12	17.6%	97.4*	1	0.791	3836
1.08	15238	6974	9086	76.8%	23.2%	24.6%	13646	3.57	29.9%	89.8*	-1	0.698	103
1.02	4393	3248	9654	33.6%	38.6%	42.0%	2239	1.41	54.1%	70.7*	0	0.000	0
total	207159	51050	60573	84.3%	3.3%	3.6%	201700	22.19	3.8%	99.9*	4	0.844	27373

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NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 209471
NUMBER OF REJECTED MISFITS                        2301
NUMBER OF SYSTEMATIC ABSENT REFLECTIONS           0
NUMBER OF ACCEPTED OBSERVATIONS                    207170
NUMBER OF UNIQUE ACCEPTED REFLECTIONS              51053

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SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 81
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COMPLETENESS AND QUALITY OF DATA SET

R-FACTOR

observed = (SUM(ABS(I(h,i)-I(h))))/(SUM(I(h,i)))
expected = expected R-FACTOR derived from Sigma(I)

COMPARED = number of reflections used for calculating R-FACTOR

I/SIGMA = mean of intensity/Sigma(I) of unique reflections
(after merging symmetry-related observations)

Sigma(I) = standard deviation of reflection intensity I
estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
random half-datasets. Correlation significant at
the 0.1% level is marked by an asterisk.
Karplus & Diederichs (2012), Science 336, 1030-33

Anomal
Corr = percentage of correlation between random half-sets
of anomalous intensity differences. Correlation
significant at the 0.1% level is marked.

SigAno = mean anomalous difference in units of its estimated
standard deviation (|F(+)-F(-)|/Sigma). F(+), F(-)
are structure factor estimates obtained from the
merged intensity observations in each parity class.

Nano = Number of unique reflections used to calculate
Anomal_Corr & SigAno. At least two observations
for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION

RESOLUTION LIMIT	NUMBER OF REFLECTIONS			COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal Corr	SigAno	Nano
	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected							
3.04	13408	2389	2499	95.6%	1.8%	2.3%	13334	67.53	2.0%	99.9*	17*	0.829	1684
2.15	25578	4235	4242	99.8%	2.3%	2.5%	25531	61.94	2.5%	99.9*	11*	0.899	3480

1.76	33621	5382	5385	99.9%	2.9%	2.9%	33595	49.97	3.1%	99.9*	8	0.909	4657
1.52	40026	6314	6314	100.0%	4.3%	4.4%	40010	35.06	4.7%	99.9*	6	0.873	5579
1.36	44846	7089	7089	100.0%	7.2%	7.2%	44836	23.02	7.8%	99.7*	2	0.837	6379
1.24	49265	7841	7842	100.0%	11.9%	12.1%	49255	14.59	13.0%	99.2*	0	0.796	7120
1.15	42768	8370	8462	98.9%	17.0%	17.6%	42632	8.81	19.0%	97.7*	1	0.778	6148
1.08	20191	7772	9086	85.5%	25.8%	27.5%	19035	3.67	32.1%	89.5*	-2	0.723	1221
1.02	5808	3855	9654	39.9%	45.5%	48.7%	3599	1.38	62.0%	68.3*	-35	0.461	18
total	275511	53247	60573	87.9%	3.5%	3.7%	271827	24.40	3.8%	100.0*	3	0.835	36286

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 278446
 NUMBER OF REJECTED MISFITS 2916
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 275530
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 53253

 SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 100

COMPLETENESS AND QUALITY OF DATA SET -----

R-FACTOR
 observed = $(\text{SUM}(\text{ABS}(I(h,i) - I(h)))) / (\text{SUM}(I(h,i)))$
 expected = expected R-FACTOR derived from $\text{Sigma}(I)$

COMPARED = number of reflections used for calculating R-FACTOR
 I/SIGMA = mean of intensity/ $\text{Sigma}(I)$ of unique reflections
 (after merging symmetry-related observations)
 $\text{Sigma}(I)$ = standard deviation of reflection intensity I
 estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
 Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
 random half-datasets. Correlation significant at
 the 0.1% level is marked by an asterisk.
 Karplus & Diederichs (2012), Science 336, 1030-33

Anomal
 Corr = percentage of correlation between random half-sets
 of anomalous intensity differences. Correlation
 significant at the 0.1% level is marked.

SigAno = mean anomalous difference in units of its estimated
 standard deviation $(|F(+) - F(-)| / \text{Sigma})$. $F(+)$, $F(-)$
 are structure factor estimates obtained from the
 merged intensity observations in each parity class.

Nano = Number of unique reflections used to calculate
 Anomal_Corr & SigAno. At least two observations
 for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION													
RESOLUTION	NUMBER OF REFLECTIONS			COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal	SigAno	Nano
LIMIT	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected					Corr		
3.04	16728	2402	2499	96.1%	1.9%	2.4%	16688	75.03	2.0%	100.0*	18*	0.872	1711
2.15	31661	4240	4242	100.0%	2.3%	2.5%	31648	68.33	2.5%	100.0*	12*	0.924	3523
1.76	41572	5383	5385	100.0%	3.0%	3.0%	41568	54.83	3.2%	99.9*	9	0.916	4692
1.52	49463	6314	6314	100.0%	4.5%	4.6%	49459	38.17	4.9%	99.9*	6	0.875	5623
1.36	55412	7089	7089	100.0%	7.6%	7.7%	55408	24.86	8.2%	99.8*	3	0.840	6409
1.24	60855	7842	7842	100.0%	12.8%	12.9%	60848	15.67	13.7%	99.3*	-1	0.797	7147
1.15	52780	8411	8462	99.4%	18.2%	19.0%	52694	9.42	19.9%	98.0*	2	0.784	6916
1.08	24944	7956	9086	87.6%	28.3%	30.4%	24114	3.85	33.9%	89.9*	-1	0.735	2822
1.02	7153	4228	9654	43.8%	49.6%	53.0%	5030	1.40	65.5%	65.8*	0	0.688	79
total	340568	53865	60573	88.9%	3.6%	3.9%	337457	26.38	3.9%	100.0*	3	0.838	38922

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 343910
 NUMBER OF REJECTED MISFITS 3309
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 340601
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 53874

 SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 120

COMPLETENESS AND QUALITY OF DATA SET

R-FACTOR

observed = (SUM(ABS(I(h,i)-I(h))))/(SUM(I(h,i)))
 expected = expected R-FACTOR derived from Sigma(I)

COMPARED = number of reflections used for calculating R-FACTOR

I/SIGMA = mean of intensity/Sigma(I) of unique reflections
(after merging symmetry-related observations)

Sigma(I) = standard deviation of reflection intensity I
estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
 Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
 random half-datasets. Correlation significant at
 the 0.1% level is marked by an asterisk.

Karplus & Diederichs (2012), Science 336, 1030-33
 Anomal Corr = percentage of correlation between random half-sets
 of anomalous intensity differences. Correlation

SigAno = significant at the 0.1% level is marked.
 = mean anomalous difference in units of its estimated standard deviation ($|F(+)-F(-)|/\text{Sigma}$). $F(+)$, $F(-)$ are structure factor estimates obtained from the merged intensity observations in each parity class.
 Nano = Number of unique reflections used to calculate Anomal_Corr & SigAno. At least two observations for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE ≥ -3.0 AS FUNCTION OF RESOLUTION												SigAno	Nano
RESOLUTION LIMIT	NUMBER OF REFLECTIONS			COMPLETENESS OF DATA	R-FACTOR observed	R-FACTOR expected	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal Corr		
	OBSERVED	UNIQUE	POSSIBLE										
3.04	20203	2410	2499	96.4%	1.9%	2.4%	20170	81.90	2.1%	100.0*	20*	0.904	1728
2.15	38107	4240	4242	100.0%	2.4%	2.6%	38096	74.46	2.6%	100.0*	13*	0.957	3536
1.76	50033	5383	5385	100.0%	3.1%	3.1%	50029	59.52	3.2%	99.9*	12*	0.954	4695
1.52	59407	6314	6314	100.0%	4.7%	4.7%	59403	41.26	4.9%	99.9*	7	0.890	5623
1.36	66533	7089	7089	100.0%	7.8%	7.9%	66530	26.77	8.3%	99.8*	4	0.851	6410
1.24	73068	7841	7842	100.0%	13.2%	13.4%	73066	16.86	13.9%	99.4*	0	0.795	7151
1.15	63400	8419	8462	99.5%	18.8%	19.6%	63378	10.14	20.2%	98.3*	0	0.771	7376
1.08	29926	7984	9086	87.9%	29.6%	32.0%	29450	4.14	34.4%	91.2*	0	0.729	3930
1.02	8597	4308	9654	44.6%	52.9%	56.8%	6964	1.49	67.8%	65.6*	1	0.685	384
total	409274	53988	60573	89.1%	3.7%	4.0%	407086	28.54	4.0%	100.0*	4	0.842	40833

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 413103
 NUMBER OF REJECTED MISFITS 3788
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 409315
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 53998

 SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 140

COMPLETENESS AND QUALITY OF DATA SET -----

R-FACTOR
 observed = $(\text{SUM}(\text{ABS}(I(h,i)-I(h))))/(\text{SUM}(I(h,i)))$
 expected = expected R-FACTOR derived from $\text{Sigma}(I)$

 COMPARED = number of reflections used for calculating R-FACTOR
 I/SIGMA = mean of intensity/ $\text{Sigma}(I)$ of unique reflections
 (after merging symmetry-related observations)
 $\text{Sigma}(I)$ = standard deviation of reflection intensity I
 estimated from sample statistics

 R-meas = redundancy independent R-factor (intensities)

Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from random half-datasets. Correlation significant at the 0.1% level is marked by an asterisk.
 Karplus & Diederichs (2012), Science 336, 1030-33
 Anomal Corr = percentage of correlation between random half-sets of anomalous intensity differences. Correlation significant at the 0.1% level is marked.
 SigAno = mean anomalous difference in units of its estimated standard deviation ($|F(+)-F(-)|/\text{Sigma}$). F(+), F(-) are structure factor estimates obtained from the merged intensity observations in each parity class.
 Nano = Number of unique reflections used to calculate Anomal_Corr & SigAno. At least two observations for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION													
RESOLUTION	NUMBER OF REFLECTIONS			COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal	SigAno	Nano
LIMIT	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected					Corr		
3.04	23599	2423	2499	97.0%	2.0%	2.4%	23564	88.25	2.1%	100.0*	25*	0.958	1746
2.15	44536	4239	4242	99.9%	2.4%	2.6%	44528	80.62	2.6%	100.0*	16*	1.006	3544
1.76	58469	5384	5385	100.0%	3.1%	3.1%	58466	64.41	3.3%	100.0*	15*	0.988	4705
1.52	69339	6314	6314	100.0%	4.7%	4.8%	69335	44.63	4.9%	99.9*	9	0.901	5626
1.36	77616	7089	7089	100.0%	7.9%	8.0%	77613	28.95	8.3%	99.8*	5	0.853	6412
1.24	85227	7841	7842	100.0%	13.2%	13.4%	85225	18.23	13.8%	99.5*	0	0.798	7151
1.15	74026	8419	8462	99.5%	19.0%	19.9%	74011	10.94	20.1%	98.5*	2	0.776	7625
1.08	34918	7990	9086	87.9%	30.1%	32.7%	34535	4.44	34.2%	92.0*	1	0.725	4537
1.02	10047	4337	9654	44.9%	53.8%	57.8%	8776	1.60	67.0%	67.4*	4	0.730	640
total	477777	54036	60573	89.2%	3.7%	4.0%	476053	30.85	4.0%	100.0*	5	0.853	41986

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 482039
 NUMBER OF REJECTED MISFITS 4219
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 477820
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 54045

 SUMMARY OF DATA SET STATISTICS FOR IMAGE DATA_RANGE= 1 160

COMPLETENESS AND QUALITY OF DATA SET -----

R-FACTOR
 observed = $(\text{SUM}(\text{ABS}(I(h,i)-I(h))))/(\text{SUM}(I(h,i)))$
 expected = expected R-FACTOR derived from $\text{Sigma}(I)$

COMPARED = number of reflections used for calculating R-FACTOR
 I/SIGMA = mean of intensity/Sigma(I) of unique reflections
 (after merging symmetry-related observations)
 Sigma(I) = standard deviation of reflection intensity I
 estimated from sample statistics

 R-meas = redundancy independent R-factor (intensities)
 Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

 CC(1/2) = percentage of correlation between intensities from
 random half-datasets. Correlation significant at
 the 0.1% level is marked by an asterisk.
 Karplus & Diederichs (2012), Science 336, 1030-33
 Anomal Corr = percentage of correlation between random half-sets
 of anomalous intensity differences. Correlation
 significant at the 0.1% level is marked.
 SigAno = mean anomalous difference in units of its estimated
 standard deviation ($|F(+)-F(-)|/\text{Sigma}$). F(+), F(-)
 are structure factor estimates obtained from the
 merged intensity observations in each parity class.
 Nano = Number of unique reflections used to calculate
 Anomal_Corr & SigAno. At least two observations
 for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE >= -3.0 AS FUNCTION OF RESOLUTION													
RESOLUTION LIMIT	NUMBER OF REFLECTIONS			COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal Corr	SigAno	Nano
	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected							
3.04	27032	2434	2499	97.4%	2.0%	2.5%	27004	94.67	2.1%	100.0*	29*	1.005	1758
2.15	50985	4239	4242	99.9%	2.5%	2.6%	50981	86.83	2.6%	100.0*	21*	1.032	3556
1.76	66840	5384	5385	100.0%	3.1%	3.1%	66840	69.44	3.2%	100.0*	16*	1.020	4707
1.52	79326	6314	6314	100.0%	4.6%	4.7%	79326	48.30	4.8%	99.9*	12*	0.921	5626
1.36	88719	7089	7089	100.0%	7.7%	7.9%	88719	31.41	8.1%	99.8*	4	0.861	6412
1.24	97481	7841	7842	100.0%	12.9%	13.2%	97481	19.85	13.5%	99.6*	1	0.802	7151
1.15	84608	8419	8462	99.5%	18.6%	19.6%	84599	11.91	19.7%	98.8*	3	0.777	7695
1.08	39947	7990	9086	87.9%	29.9%	32.5%	39775	4.86	33.5%	93.1*	0	0.730	5570
1.02	11497	4371	9654	45.3%	53.4%	57.5%	10725	1.74	65.9%	68.4*	2	0.713	993
total	546435	54081	60573	89.3%	3.7%	4.0%	545450	33.33	3.9%	100.0*	5	0.861	43468

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 551062
 NUMBER OF REJECTED MISFITS 4584
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 546478
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 54090

 STATISTICS OF SAVED DATA SET "XDS_ASCII.HKL" (DATA_RANGE= 1 180)
 FILE TYPE: XDS_ASCII MERGE=FALSE FRIEDEL'S_LAW=TRUE

REFLECTIONS OF TYPE H,0,0 0,K,0 0,0,L OR EXPECTED TO BE ABSENT (*)



H	K	L	RESOLUTION	INTENSITY	SIGMA	INTENSITY/SIGMA	#OBSERVED
0	0	8	4.614	0.7361E+05	0.2350E+04	31.33	1
0	0	9	4.102	-0.1968E+02	0.4141E+02	-0.48	1
0	0	10	3.691	0.1230E+03	0.5639E+02	2.18	1
0	0	11	3.356	-0.7356E+02	0.5851E+02	-1.26	1
0	0	12	3.076	0.2228E+05	0.7226E+03	30.84	1
0	0	13	2.840	-0.1790E+02	0.5949E+02	-0.30	1
0	0	14	2.637	0.7811E+02	0.6518E+02	1.20	1
0	0	15	2.461	-0.2592E+02	0.4060E+02	-0.64	2
0	0	16	2.307	0.1708E+06	0.3853E+04	44.32	2
0	0	17	2.171	-0.3198E+02	0.5485E+02	-0.58	2
0	0	18	2.051	-0.2976E+02	0.5702E+02	-0.52	2
0	0	19	1.943	0.7446E+02	0.5368E+02	1.39	2
0	0	20	1.846	0.8714E+04	0.2139E+03	40.73	2
0	0	21	1.758	-0.7099E+02	0.4920E+02	-1.44	2
0	0	22	1.678	0.1030E+03	0.5982E+02	1.72	2
0	0	23	1.605	0.9994E+02	0.6638E+02	1.51	2
0	0	24	1.538	0.1180E+04	0.7949E+02	14.85	2
0	0	25	1.477	0.3050E+02	0.6789E+02	0.45	2
0	0	26	1.420	0.6007E+01	0.6335E+02	0.09	2
0	0	27	1.367	-0.4061E+01	0.6536E+02	-0.06	2
0	0	28	1.318	0.2548E+04	0.1016E+03	25.07	2
0	0	29	1.273	-0.6040E+02	0.7801E+02	-0.77	2
0	0	30	1.230	0.1556E+01	0.8774E+02	0.02	2
2	0	0	39.489	-0.3602E+01	0.9342E+00	-3.86	3
3	0	0	26.326	0.7301E+01	0.2292E+01	3.19	4
4	0	0	19.744	0.3432E+05	0.1097E+04	31.29	1
5	0	0	15.795	0.3027E+01	0.4373E+01	0.69	4
6	0	0	13.163	0.5954E+04	0.9628E+02	61.84	4
7	0	0	11.282	-0.5694E+01	0.6785E+01	-0.84	4
9	0	0	8.775	-0.2007E+02	0.9036E+01	-2.22	4
11	0	0	7.180	-0.2971E+02	0.1077E+02	-2.76	4
12	0	0	6.581	0.8352E+05	0.2664E+04	31.35	1
13	0	0	6.075	-0.3640E+02	0.1299E+02	-2.80	4
14	0	0	5.641	0.3120E+04	0.5493E+02	56.80	4
15	0	0	5.265	-0.1380E+02	0.1603E+02	-0.86	4
17	0	0	4.646	-0.2415E+02	0.1946E+02	-1.24	4
19	0	0	4.157	-0.1062E+03	0.2393E+02	-4.44	4
20	0	0	3.949	0.7402E+05	0.1184E+04	62.52	4
21	0	0	3.761	-0.7724E+02	0.2923E+02	-2.64	4
22	0	0	3.590	0.2337E+04	0.5128E+02	45.58	4
23	0	0	3.434	0.2737E+03	0.4082E+02	6.70	3
24	0	0	3.291	0.1493E+05	0.2455E+03	60.82	4
25	0	0	3.159	-0.1427E+03	0.3105E+02	-4.60	4
26	0	0	3.038	0.8785E+05	0.1405E+04	62.54	4
27	0	0	2.925	-0.4403E+02	0.2957E+02	-1.49	4
28	0	0	2.821	0.1596E+03	0.3492E+02	4.57	4

29	0	0	2.723	-0.3775E+02	0.3709E+02	-1.02	3
30	0	0	2.633	0.2309E+05	0.3758E+03	61.45	4
31	0	0	2.548	-0.1491E+03	0.3508E+02	-4.25	4
32	0	0	2.468	0.2378E+04	0.6495E+02	36.60	3
33	0	0	2.393	-0.7946E+02	0.3559E+02	-2.23	4
34	0	0	2.323	0.3269E+05	0.5285E+03	61.85	4
35	0	0	2.256	-0.2190E+02	0.3709E+02	-0.59	4
36	0	0	2.194	0.3120E+03	0.3980E+02	7.84	4
37	0	0	2.135	-0.9380E+01	0.3744E+02	-0.25	4
38	0	0	2.078	0.8514E+04	0.1486E+03	57.29	4
39	0	0	2.025	-0.9324E+02	0.3416E+02	-2.73	4
40	0	0	1.974	0.1704E+05	0.2815E+03	60.54	4
41	0	0	1.926	-0.6684E+02	0.3585E+02	-1.86	4
42	0	0	1.880	0.8117E+03	0.4392E+02	18.48	4
43	0	0	1.837	-0.8298E+02	0.3932E+02	-2.11	4
44	0	0	1.795	0.8554E+04	0.1500E+03	57.02	4
45	0	0	1.755	-0.5122E+00	0.4094E+02	-0.01	4
46	0	0	1.717	0.3103E+04	0.6867E+02	45.19	4
47	0	0	1.680	-0.1463E+02	0.4231E+02	-0.35	4
48	0	0	1.645	0.6151E+04	0.1154E+03	53.30	4
49	0	0	1.612	-0.6080E+02	0.4453E+02	-1.37	4
50	0	0	1.580	0.2183E+04	0.6476E+02	33.71	4
51	0	0	1.549	-0.1668E+02	0.4376E+02	-0.38	4
52	0	0	1.519	0.1384E+04	0.5697E+02	24.30	4
53	0	0	1.490	-0.6971E+02	0.4411E+02	-1.58	4
54	0	0	1.463	0.1060E+05	0.1871E+03	56.69	4
55	0	0	1.436	-0.5124E+02	0.4730E+02	-1.08	4
56	0	0	1.410	0.6853E+04	0.1310E+03	52.31	4
57	0	0	1.386	-0.2501E+02	0.4847E+02	-0.52	4
58	0	0	1.362	0.4307E+03	0.5165E+02	8.34	4
59	0	0	1.339	-0.5574E+02	0.5184E+02	-1.08	4
60	0	0	1.316	0.3193E+03	0.5022E+02	6.36	4
61	0	0	1.295	-0.1504E+03	0.5655E+02	-2.66	4
62	0	0	1.274	0.6526E+04	0.1255E+03	51.98	4
63	0	0	1.254	0.1817E+02	0.5824E+02	0.31	4
64	0	0	1.234	0.8310E+03	0.6046E+02	13.75	4
65	0	0	1.215	0.7398E+02	0.6063E+02	1.22	4
66	0	0	1.197	0.2604E+03	0.5755E+02	4.52	4
67	0	0	1.179	-0.9247E+00	0.6380E+02	-0.01	4
68	0	0	1.161	-0.1625E+02	0.6654E+02	-0.24	4
69	0	0	1.145	-0.6330E+02	0.6373E+02	-0.99	4
70	0	0	1.128	0.1065E+03	0.1137E+03	0.94	2
71	0	0	1.112	-0.8464E+02	0.1007E+03	-0.84	2

COMPLETENESS AND QUALITY OF DATA SET

R-FACTOR

observed = (SUM(ABS(I(h,i)-I(h))))/(SUM(I(h,i)))

expected = expected R-FACTOR derived from Sigma(I)

COMPARED = number of reflections used for calculating R-FACTOR

I/SIGMA = mean of intensity/Sigma(I) of unique reflections

Sigma(I) = (after merging symmetry-related observations)
 = standard deviation of reflection intensity I
 estimated from sample statistics

R-meas = redundancy independent R-factor (intensities)
 Diederichs & Karplus (1997), Nature Struct. Biol. 4, 269-275.

CC(1/2) = percentage of correlation between intensities from
 random half-datasets. Correlation significant at
 the 0.1% level is marked by an asterisk.
 Karplus & Diederichs (2012), Science 336, 1030-33

Anomal
 Corr = percentage of correlation between random half-sets
 of anomalous intensity differences. Correlation
 significant at the 0.1% level is marked.

SigAno = mean anomalous difference in units of its estimated
 standard deviation ($|F(+)-F(-)|/\text{Sigma}$). F(+), F(-)
 are structure factor estimates obtained from the
 merged intensity observations in each parity class.

Nano = Number of unique reflections used to calculate
 Anomal_Corr & SigAno. At least two observations
 for each (+ and -) parity are required.

SUBSET OF INTENSITY DATA WITH SIGNAL/NOISE ≥ -3.0 AS FUNCTION OF RESOLUTION

RESOLUTION	NUMBER	OF REFLECTIONS	COMPLETENESS	R-FACTOR	R-FACTOR	COMPARED	I/SIGMA	R-meas	CC(1/2)	Anomal	SigAno	Nano	
LIMIT	OBSERVED	UNIQUE	POSSIBLE	OF DATA	observed	expected				Corr			
3.04	27673	2434	2499	97.4%	2.0%	2.5%	27647	95.91	2.1%	100.0*	31*	1.016	1759
2.15	52200	4240	4242	100.0%	2.5%	2.6%	52198	87.93	2.6%	100.0*	21*	1.042	3556
1.76	68400	5384	5385	100.0%	3.1%	3.1%	68400	70.38	3.2%	100.0*	18*	1.024	4707
1.52	81204	6314	6314	100.0%	4.6%	4.7%	81204	49.00	4.8%	99.9*	11*	0.933	5626
1.36	90823	7089	7089	100.0%	7.7%	7.8%	90823	31.91	8.0%	99.9*	5	0.858	6412
1.24	99789	7840	7842	100.0%	12.9%	13.1%	99789	20.17	13.4%	99.6*	0	0.802	7150
1.15	86618	8419	8462	99.5%	18.6%	19.5%	86609	12.12	19.5%	98.8*	1	0.773	7698
1.08	40899	7990	9086	87.9%	29.8%	32.4%	40772	4.95	33.3%	93.1*	2	0.733	5746
1.02	11782	4373	9654	45.3%	53.3%	57.4%	11139	1.78	65.8%	68.2*	2	0.717	1086
total	559388	54083	60573	89.3%	3.7%	4.0%	558581	33.81	3.9%	100.0*	5	0.863	43740

NUMBER OF REFLECTIONS IN SELECTED SUBSET OF IMAGES 564183
 NUMBER OF REJECTED MISFITS 4738
 NUMBER OF SYSTEMATIC ABSENT REFLECTIONS 0
 NUMBER OF ACCEPTED OBSERVATIONS 559445
 NUMBER OF UNIQUE ACCEPTED REFLECTIONS 54093

 WILSON STATISTICS OF DATA SET "XDS_ASCII.HKL"

Data is divided into resolution shells and a straight line
 $A - 2*B*SS$ is fitted to $\log\langle I \rangle$, where

RES = mean resolution (Angstrom) in shell
 SS = mean of $(\sin(\text{THETA})/\text{LAMBDA})^2$ in shell
 <I> = mean reflection intensity in shell
 B0 = $(A - \log\langle I \rangle)/(2 \cdot SS)$
 # = number of reflections in resolution shell

WILSON LINE (using all data) : A= 10.163 B= 11.317 CORRELATION= 0.98

#	RES	SS	<I>	log(<I>)	B0
829	5.708	0.008	2.3983E+04	10.085	5.1
1424	3.571	0.020	3.7261E+04	10.526	-9.3
1809	2.787	0.032	1.5625E+04	9.657	7.9
2116	2.360	0.045	1.0413E+04	9.251	10.2
2359	2.084	0.058	7.2283E+03	8.886	11.1
2612	1.886	0.070	4.2438E+03	8.353	12.9
2804	1.736	0.083	2.7299E+03	7.912	13.6
3027	1.616	0.096	2.0920E+03	7.646	13.1
3177	1.518	0.108	1.5307E+03	7.333	13.0
3377	1.436	0.121	1.1592E+03	7.055	12.8
3527	1.366	0.134	8.9642E+02	6.798	12.6
3673	1.306	0.147	7.5823E+02	6.631	12.0
3832	1.253	0.159	6.0878E+02	6.411	11.8
4012	1.205	0.172	5.4225E+02	6.296	11.2
4047	1.163	0.185	4.5390E+02	6.118	10.9
3915	1.125	0.197	3.8639E+02	5.957	10.7
3530	1.091	0.210	3.0021E+02	5.704	10.6
2813	1.060	0.223	2.1307E+02	5.362	10.8
1198	1.034	0.234	1.5330E+02	5.032	11.0

HIGHER ORDER MOMENTS OF WILSON DISTRIBUTION OF CENTRIC DATA
AS COMPARED WITH THEORETICAL VALUES. (EXPECTED: 1.00)

#	RES	$\frac{\langle I^2 \rangle}{3\langle I \rangle^2}$	$\frac{\langle I^3 \rangle}{15\langle I \rangle^3}$	$\frac{\langle I^4 \rangle}{105\langle I \rangle^4}$
292	5.708	0.575	0.399	0.254
312	3.571	0.803	0.555	0.317
327	2.787	0.867	0.727	0.559
321	2.360	0.934	0.883	0.748
320	2.084	1.189	1.522	1.964
328	1.886	0.844	0.703	0.517
324	1.736	0.886	0.809	0.648
323	1.616	0.866	0.746	0.603
321	1.518	1.113	1.248	1.383
329	1.436	0.951	1.126	1.324
320	1.366	1.010	1.087	1.159
320	1.306	1.218	1.193	1.082
323	1.253	0.847	0.722	0.558
332	1.205	0.755	0.725	0.708
294	1.163	0.960	0.866	0.708
254	1.125	1.102	1.082	0.973
187	1.091	1.140	0.997	0.746
106	1.060	1.117	1.087	0.960
30	1.034	1.711	1.943	2.030

5363 overall 0.947 0.913 0.852

HIGHER ORDER MOMENTS OF WILSON DISTRIBUTION OF ACENTRIC DATA
AS COMPARED WITH THEORETICAL VALUES. (EXPECTED: 1.00)

#	RES	$\langle I^2 \rangle / 2 \langle I \rangle^2$	$\langle I^3 \rangle / 6 \langle I \rangle^3$	$\langle I^4 \rangle / 24 \langle I \rangle^4$
537	5.708	1.169	1.141	1.031
1112	3.571	0.986	0.902	0.763
1482	2.787	1.009	0.964	0.861
1795	2.360	1.007	0.992	0.967
2039	2.084	1.016	1.072	1.198
2284	1.886	1.049	1.090	1.096
2480	1.736	1.032	1.094	1.227
2704	1.616	0.979	0.922	0.839
2856	1.518	0.977	0.937	0.864
3048	1.436	0.983	0.936	0.882
3207	1.366	1.008	0.996	0.958
3353	1.306	0.976	0.949	0.906
3509	1.253	0.976	0.919	0.869
3680	1.205	1.064	1.114	1.130
3753	1.163	1.017	1.012	0.989
3661	1.125	1.017	1.010	0.988
3343	1.091	1.107	1.266	1.564
2707	1.060	1.183	1.265	1.339
1168	1.034	1.505	1.554	1.764
48718	overall	1.037	1.045	1.055

===== CUMULATIVE INTENSITY DISTRIBUTION =====

DEFINITIONS:

$\langle I \rangle$ = mean reflection intensity
 $N_a(Z)_{\text{exp}}$ = expected number of acentric reflections with $I \leq Z \langle I \rangle$
 $N_a(Z)_{\text{obs}}$ = observed number of acentric reflections with $I \leq Z \langle I \rangle$
 $N_c(Z)_{\text{exp}}$ = expected number of centric reflections with $I \leq Z \langle I \rangle$
 $N_c(Z)_{\text{obs}}$ = observed number of centric reflections with $I \leq Z \langle I \rangle$

$N_c(Z)_{\text{obs}}/N_c(Z)_{\text{exp}}$ versus resolution and Z (0.1-1.0)

#	RES	0.1	0.2	0.3	0.4	0.5	0.6	0.7	0.8	0.9	1.0
292	5.708	1.03	1.10	1.06	1.03	1.01	1.03	1.06	1.08	1.08	1.10
312	3.571	1.08	1.06	1.03	1.06	1.05	1.03	1.03	1.01	1.03	1.01
327	2.787	1.02	0.99	1.00	0.97	0.97	0.98	0.97	0.99	1.01	1.03
321	2.360	1.14	1.05	1.05	1.03	1.04	1.05	1.03	1.04	1.05	1.03
320	2.084	1.01	1.06	1.03	1.08	1.07	1.06	1.07	1.05	1.05	1.04
328	1.886	0.95	1.01	1.01	1.01	0.99	1.00	1.04	1.04	1.04	1.03
324	1.736	1.17	1.12	1.09	1.10	1.07	1.04	1.07	1.07	1.04	1.06
323	1.616	0.98	1.07	1.02	1.00	0.98	0.99	0.99	0.97	0.99	1.00
321	1.518	0.93	0.89	0.90	0.91	0.90	0.91	0.93	0.96	0.94	0.95
329	1.436	1.11	1.13	1.09	1.09	1.06	1.09	1.08	1.07	1.06	1.06
320	1.366	0.91	0.95	1.02	1.06	1.10	1.09	1.07	1.07	1.06	1.07

320	1.306	1.02	0.99	0.97	0.97	0.98	0.96	0.93	0.92	0.93	0.95
323	1.253	1.06	0.99	1.03	1.08	1.06	1.01	1.01	1.04	1.05	1.04
332	1.205	0.96	1.05	1.10	1.06	1.09	1.11	1.14	1.11	1.11	1.10
294	1.163	0.93	0.89	0.94	0.97	1.03	1.04	1.02	1.00	0.99	0.99
254	1.125	0.90	0.92	0.93	0.98	0.95	0.95	0.94	0.93	0.93	0.95
187	1.091	1.12	0.88	0.83	0.81	0.88	0.91	0.94	0.97	0.99	0.96
106	1.060	0.99	0.90	0.93	0.94	0.94	0.92	0.96	0.96	0.98	1.00
30	1.034	1.88	1.35	1.20	1.06	0.96	1.01	0.95	0.90	0.86	0.88
5363	overall	1.02	1.01	1.01	1.02	1.02	1.02	1.02	1.02	1.02	1.02

Na(Z)obs/Na(Z)exp versus resolution and Z (0.1-1.0)											
#	RES	0.1	0.2	0.3	0.4	0.5	0.6	0.7	0.8	0.9	1.0
537	5.708	0.88	0.91	0.94	0.93	0.91	0.86	0.85	0.89	0.91	0.94
1112	3.571	0.77	0.88	0.95	0.98	0.96	0.99	1.00	1.00	0.99	0.99
1482	2.787	1.06	1.02	1.00	1.03	1.02	1.01	1.01	1.01	1.00	0.99
1795	2.360	0.94	0.93	0.92	0.96	0.99	1.00	1.01	1.01	1.00	1.00
2039	2.084	0.95	1.01	1.02	1.00	1.02	1.01	1.02	1.00	1.01	1.01
2284	1.886	1.04	1.02	1.00	1.01	1.02	1.02	1.03	1.02	1.01	1.01
2480	1.736	0.88	0.96	0.98	0.99	0.99	0.98	0.98	0.98	0.99	0.99
2704	1.616	1.01	0.96	0.96	0.97	0.97	0.99	0.99	0.98	0.99	0.99
2856	1.518	0.98	1.00	0.98	1.03	1.03	1.02	1.01	1.01	0.99	1.00
3048	1.436	0.90	0.90	0.91	0.96	0.96	0.96	0.96	0.98	0.98	0.98
3207	1.366	1.06	0.98	0.97	0.98	0.99	1.00	1.00	1.00	1.00	1.00
3353	1.306	1.17	1.04	1.03	1.03	1.01	1.01	1.00	1.01	1.00	0.99
3509	1.253	1.03	0.96	0.96	0.95	0.94	0.95	0.97	0.98	0.98	0.99
3680	1.205	1.11	1.02	0.99	1.00	1.00	1.00	1.00	0.99	1.00	0.99
3753	1.163	1.15	1.04	1.04	1.01	1.00	1.01	1.00	1.00	0.99	0.99
3661	1.125	1.31	1.08	1.02	1.02	1.00	0.99	0.99	0.99	0.99	0.98
3343	1.091	1.57	1.16	1.06	1.01	1.00	0.99	0.98	0.98	0.98	0.99
2707	1.060	2.06	1.32	1.07	0.99	0.95	0.95	0.95	0.93	0.94	0.95
1168	1.034	2.63	1.54	1.19	1.05	0.96	0.91	0.89	0.86	0.87	0.86
48718	overall	1.18	1.04	1.00	1.00	0.99	0.99	0.99	0.99	0.99	0.99

List of 4 reflections *NOT* obeying Wilson distribution (Z> 10.0)

h	k	l	RES	Z	Intensity	Sigma
28	16	30	1.10	12.57	0.3774E+04	0.1106E+03 "alien"
32	28	5	1.80	10.98	0.2999E+05	0.2827E+03 "alien"
62	11	5	1.24	10.22	0.6220E+04	0.6805E+02 "alien"
8	7	16	2.20	10.13	0.7324E+05	0.7421E+03 "alien"

List of 4 reflections *NOT* obeying Wilson distribution (sorted by resolution)
Ice rings could occur at (Angstrom):
3.897,3.669,3.441, 2.671,2.249,2.072, 1.948,1.918,1.883,1.721

h	k	l	RES	Z	Intensity	Sigma
28	16	30	1.10	12.57	0.3774E+04	0.1106E+03

62	11	5	1.24	10.22	0.6220E+04	0.6805E+02
32	28	5	1.80	10.98	0.2999E+05	0.2827E+03
8	7	16	2.20	10.13	0.7324E+05	0.7421E+03

NUMBER OF UNIQUE ALIEN REFLECTIONS WITH A Z-SCORE ABOVE LIMIT 0
(ALIENS ABOVE LIMIT (REJECT_ALIEN= 20.0) ARE MARKED INVALID)

NUMBER OF REFLECTION RECORDS ON OUTPUT FILE "XDS_ASCII.HKL"	564183
NUMBER OF ACCEPTED OBSERVATIONS (INCLUDING SYSTEMATIC ABSENCES)	559445
NUMBER OF REJECTED MISFITS & ALIENS (marked by -1*SIGMA(IOBS))	4738

cpu time used	82.4 sec
elapsed wall-clock time	14.7 sec